

# Search Notes



Application/Control No.

10/635,689

Examiner

Lan Nguyen

Applicant(s)/Patent under Reexamination

YASUMOTO ET AL.

Art Unit

3683

## SEARCHED

Class	Subclass	Date	Examiner
188	378-380	8/11/06	XLN
267	140.12		
	292		
	293		
74	492		
	552		
280	728.2		
	731		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
TEXT Search included	8/11/06	XLN
JP Translation Request JP-2824382		
JP-02057475 JP-4-46246		
Update inventor search	12/29/06	XLN